

Search Notes

Application/Control No.

10/525,186

Examiner

Binh X. Tran

Applicant(s)/Patent under
Reexamination

REHOREK ET AL.

Art Unit

1792

SEARCHED

Class	Subclass	Date	Examiner
427	376.1	12/5/2008	BT
427	383.5	12/5/2008	BT
427	389.7	12/5/2008	BT

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Search inventor's names	12/5/2008	BT
Search keywords using databases in EAST	12/5/2008	BT